


FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. <b>00169.001469.1</b>		APPLICATION NO. <b>09/801,688</b>	
<div style="border: 2px solid black; border-radius: 50%; padding: 10px; display: inline-block;">             RECEIVED              SEP 24 2003              PATENT &amp; TRADEMARK OFFICE           </div>				APPLICANT <b>SEPPO REINO KERONEN, ET AL.</b>			
				FILING DATE <b>March 9, 2001</b>		GROUP <b>2876</b>	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
JJS	6,408,301	06/18/02	Patton et al.	707	102		
JJS	6,308,202	10/23/01	Cohn et al	709	217		
JJS	6,229,694	05/08/01	Kono	361	683		
JJS	6,072,980	06/06/00	Manico et al.	434	317		
JJS	6,014,593	01/11/00	Gruftman	700	136		
JJS	5,973,475	10/26/99	Combaluzier	320	107		
JJS	5,914,707	06/22/99	Kono	345	173		
JJS	5,878,292	03/02/99	Bell et al.	396	312		
JJS	5,845,160	12/01/98	Patton	396	312		
JJS	5,601,489	02/11/97	Komaki	463	44		
JJS	5,430,496	07/04/95	Silverbrook	348	589		
JJS	5,015,830	05/14/91	Masuzawa et al.	235	441		
JJS	5,002,062	03/26/91	Suzuki	128	696		
JJS	4,977,310	12/11/90	Studer et al.	235	375		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
JJS	400,221	12/05/90	Europe	X	X		
JJS	2721730	12/29/95	France			Abstract	
JJS	8-294080	11/05/96	Japan			Abstract	
JJS	8-129236	05/21/96	Japan			Abstract	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
JJS	"IntelliK ys, Effectiv , Powerful, and Affordabl ," product informati n, <a href="http://www.intellitools.com/intellik_ys-text.html">http://www.intellitools.com/intellik_ys-text.html</a> . No date available.						
EXAMINER <i>Paul J. J. J.</i>				DATE CONSIDERED <i>1/22/2004</i>			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809; Draw line through citation if not in conformance and not considered. Include copy form with next communication to applicant.

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U.S. PATENT DOCUMENTS													
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE							
<div style="font-size: 4em; transform: rotate(-45deg); opacity: 0.5;">X</div>													
							FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	TRANSLATION YES/NO/ OR ABSTRACT							
<i>ggg</i>	✓	59-123986	07/17/84	Japan	<div style="font-size: 4em; transform: rotate(-45deg); opacity: 0.5;">X</div>	Abstract							
<i>ggg</i>	WO	96/32702	10/17/96	PCT									
<i>ggg</i>	WO	93/07715	04/15/93	PCT									
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)													
EXAMINER <i>Paul J. Fineman</i>				DATE CONSIDERED <i>1/22/2004</i>									

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FORM PTO 1449 (modified)

ATTY DOCKET NO. 00169.001465

APPLICATION NO. 09/801,688

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

APPLICANT

SEPPO KERONEN, ET AL.

FILING DATE March 9, 2001

GROUP 2876

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<del>_____</del>	<del>5,434,395</del>	<del>7/18/95</del>	<del>Storck, et al.</del>	<del>235</del>	<del>380</del>	<del>_____</del>
<del>_____</del>	<del>5,594,493</del>	<del>1/14/97</del>	<del>Nemirofsky</del>	<del>348</del>	<del>13</del>	<del>_____</del>
<del>_____</del>	<del>5,412,416</del>	<del>5/2/95</del>	<del>Nemirofsky</del>	<del>348</del>	<del>10</del>	<del>_____</del>
<del>_____</del>	<del>6,223,340</del>	<del>4/24/01</del>	<del>Hayes, et al.</del>	<del>725</del>	<del>152</del>	<del>_____</del>
<del>_____</del>	<del>5,583,539</del>	<del>12/10/96</del>	<del>Hiketa, et al.</del>	<del>348</del>	<del>10</del>	<del>_____</del>
<del>_____</del>	<del>5,479,205</del>	<del>12/26/95</del>	<del>Silverbrook</del>	<del>348</del>	<del>239</del>	<del>_____</del>
<del>_____</del>	<del>5,353,016</del>	<del>10/4/94</del>	<del>Kurita, et al.</del>	<del>340</del>	<del>825</del>	<del>_____</del>
<del>_____</del>	<del>2001-0017616</del>	<del>2/28/01</del>	<del>Kabayashi</del>	<del>345</del>	<del>173</del>	<del>_____</del>

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<del>_____</del>	<del>9520294</del>	<del>1/14/97</del>	<del>PCT/WO</del>	<del>_____</del>	<del>_____</del>	<del>_____</del>
<del>_____</del>	<del>3,637,684</del>	<del>5/7/87</del>	<del>Germany</del>	<del>_____</del>	<del>_____</del>	<del>_____</del>
<del>_____</del>	<del>1,039,772</del>	<del>9/27/00</del>	<del>Europe</del>	<del>_____</del>	<del>_____</del>	<del>_____</del>
<del>885</del>	<del>606,287</del>	<del>7/24/94</del>	<del>Europe</del>	<del>_____</del>	<del>_____</del>	<del>_____</del>
<del>_____</del>	<del>2,696,888</del>	<del>4/15/94</del>	<del>France</del>	<del>_____</del>	<del>_____</del>	<del>_____</del>
<del>_____</del>	<del>123,986</del>	<del>7/17/84</del>	<del>Japan</del>	<del>_____</del>	<del>_____</del>	<del>_____</del>

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

<del>_____</del>	<del>_____</del>
<del>_____</del>	<del>_____</del>
<del>_____</del>	<del>_____</del>
<del>_____</del>	<del>_____</del>
<del>_____</del>	<del>_____</del>

EXAMINER

*Gene A. Timmerman*

DATE CONSIDERED

*1/22/2004*

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